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LIST OF	REFE	RENCES CITED BY A	PPLICANT	Kazushige OHNO, et al.					
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/JMG/	AO	1 142 619	10/10/01	EP		, , , ,		NO	
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Examiner /Jason M. Greene/					Date Considered 02/03/2008				
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*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									